



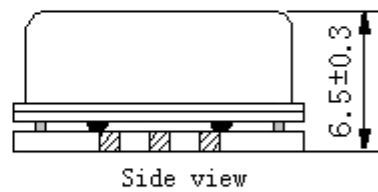
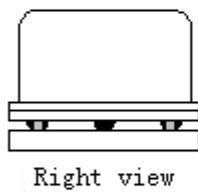
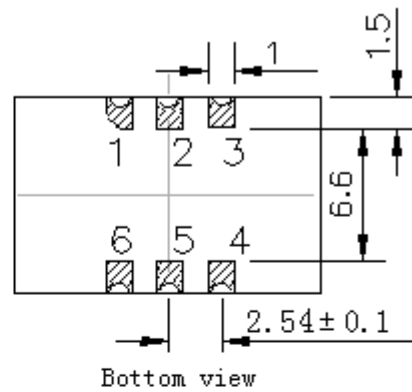
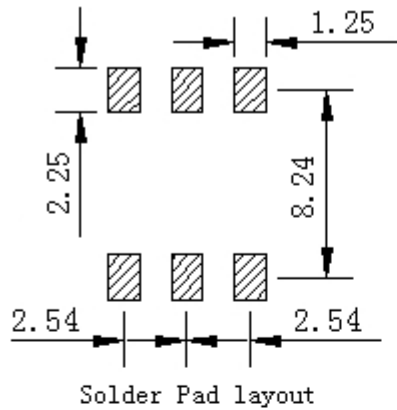
1. Electrical Parameters

MODEL: O11F-1201-20.00MHz							
Item	Description	Parameters			Unit	Test Condition	
		Min.	Typ.	Max.			
Output	Frequency	20.00			MHz		
	Output Waveform	LVCMOS					
	Output Low Voltage			0.4	V	$V_{cc}=3.3V, O_{load}=15pF$	
	Output High Voltage	2.4			V	$V_{cc}=3.3V, O_{load}=15pF$	
	Duty Cycle	45	50	55	%	@50%	
	Rise / Fall Time (10%~90%)			10	ns		
	Spurious			-60	dBc		
	Load	15			pF		
Frequency Stabilities	Frequency Tolerance vs. Operating Temperature Range	-0.05		+0.05	$\times 10^{-6}$	T_A varied from $-40^{\circ}C$ to $85^{\circ}C$, measurement referenced to frequency observed with $f_{ref}=(f_{max}+f_{min})/2$, $V_{cc}=3.3V, O_{load}=15pF$, temperature variable speed less than $2^{\circ}C$ per minute.	
	Initial Frequency Tolerance	-0.2		+0.2	$\times 10^{-6}$	Measurement referenced to frequency observed with $T_A=25^{\circ}C, V_{cc}=3.3V$, and after 15 minutes of operation, within 30 days after ex-works.	
	Frequency Tolerance vs. Supply Voltage	-10		+10	$\times 10^{-9}$	measurement referenced to frequency observed $T_A=25^{\circ}C, V_{cc}$ varied from 3.135V to 3.465V, and $O_{Load}=15pF$.	
	Frequency Tolerance vs. Load	-10		+10	$\times 10^{-9}$	5% load change measurement referenced to frequency observed with $T_A=25^{\circ}C, V_{cc}=3.3V$, and $O_{Load}=15pF$.	
	Short-Term Stability Allan Variance				0.1	$\times 10^{-9}$	1s
					0.1	$\times 10^{-9}$	10s
					0.1	$\times 10^{-9}$	100s
					0.3	$\times 10^{-9}$	1000s
					0.6	$\times 10^{-9}$	10000s
	Aging Tolerance Per Day	-5.0		+5.0	$\times 10^{-9}$	V_{cc}, T_A constant measurement referenced to frequency observed with $T_A=25^{\circ}C, V_{cc}=3.3V$, and after 30 days of operation.	
Aging Tolerance 1 Year	-0.5		+0.5	$\times 10^{-6}$			
Aging Tolerance 10 Year	-3.0		+3.0	$\times 10^{-6}$			



Power Supply	Supply Voltage	3.135	3.3	3.465	V	
	Steady Consumption			200	mA	@25°C
	Warm up current			600	mA	
	Warm-Up Time			5	minutes	@25 °C within $\pm 0.05 \times 10^{-6}$ of final frequency with reference after 1 hours on.
				-105	dBc/Hz	10Hz
				-130		100Hz
				-145		1KHz
			-150	10KHz		
Environmental Conditions	Operable Temperature	-40		+85	°C	
	Storage Temperature	-55		+105	°C	
	ESD Level	Human Body Model, class2: 2000V to 4000V; ANSI/ESDA/JEDEC JS-001-2010.				
		Machine Model, class B: 200V to 400V; ANSI/ESDA/JEDEC JS-001-2010.				
	Moisture Sensitivity Level	Level 3.				
	Vibration	Test Condition: 0.75mm ;acceleration:10g;10Hz~500Hz, one cycle per 30 min, test 2 hour. (3 times for each 3 directions X , Y , Z), IEC 68-2-06 Test Fc.				
Shock	50g; 11ms; half sine wave (3 times for each 3 directions X, Y, Z), IEC 68-2-27 Test Ea/Severity 50A.					
Full Package Storage	Relative humidity (%)	20%~70%				
	Temperature (°C)	-10~35°C				

2. Mechanical Structure (mm)



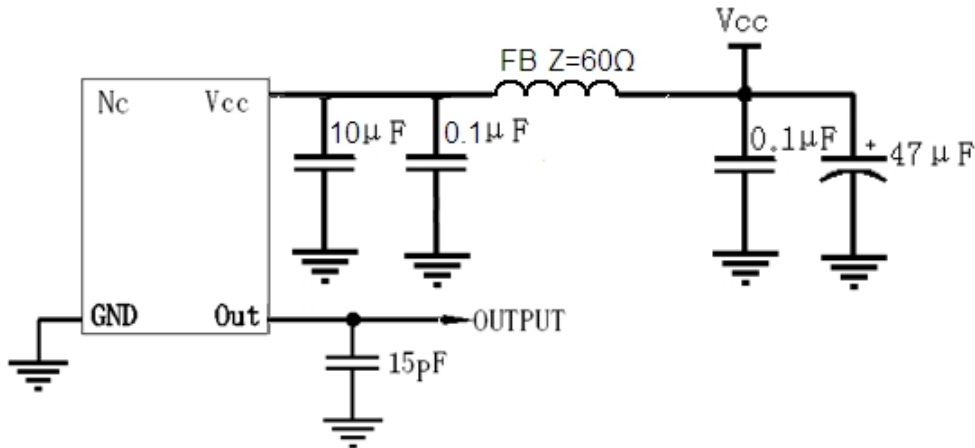
PIN FUNCTION

PIN	NOTATION	FUNCTION
1	NC	Not Connect
2,5	NC	Not Connect
3	GND	GND
4	OUTPUT	RF Output
6	VCC	Supply Voltage

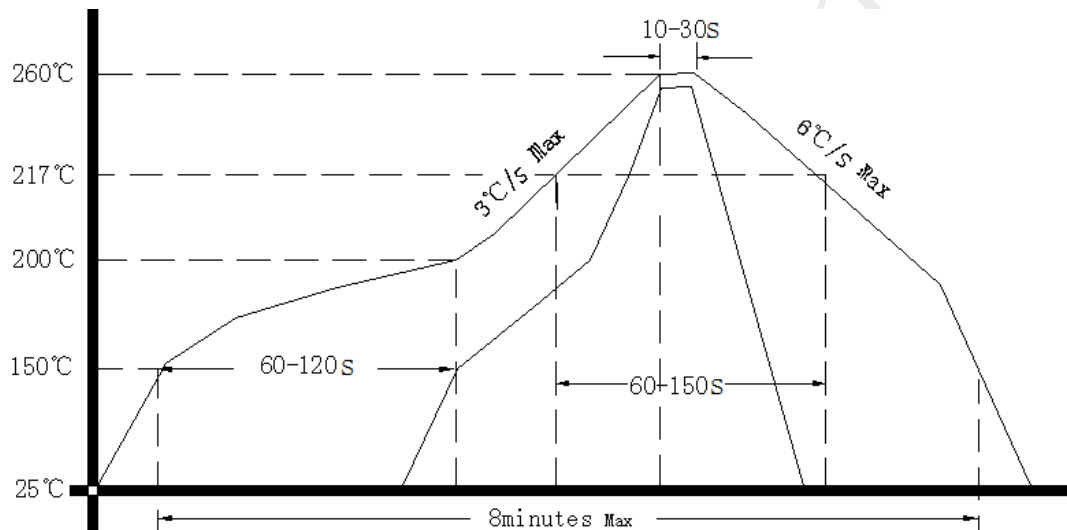


- Note1:** Tolerance $\pm 0.2\text{mm}$ without mark
- Note2:** The first two xx representative: week
After two xx representative: year
- Note3:** Referential weight 2.6g
- Note4:** NC is not connect

3. Test Circuit



4. Reflow Soldering Curve (RoHS)



Note: passing through reflow upside down is not supported

5. Package: Tape & Reel (mm)

